

Search Notes

Application/Control No.

10/506,386

Examiner

Eugenia Wang

Applicant(s)/Patent under
Reexamination

BEDNARZ ET AL.

Art Unit

1745

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor Search (eDAN); Assignee Search (EAST)	4/13/2007	EW
Keyword search (EAST) - USPAT, USPGPUB, USOCR (some limited to 429/12-26, 204, 205, especially 429/13, 16, 21)	4/16/2007	EW
Keyword Search (EAST) - JPO, EPO, DERWENT (H01M008\$.ipc.)	4/16/2007	EW